

NON-FUNCTIONAL PADS: SHOULD THEY STAY OR SHOULD THEY GO?

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Abstract

There is an ongoing debate regarding the influence of non-functional pads (NFPs) on printed board (PB) reliability, especially as related to barrel fatigue on plated through vias with high aspect ratios. To gather common practices and reliability data, industry experts were surveyed. The overwhelming response indicated that most suppliers do remove unused / non-functional pads. No adverse reliability information was noted with respect to the removal of unused pads; conversely, leaving them can lead to an issue called telegraphing. In all responses, remove or keep NFPs, the primary reason given was to improve the respective fabricators' processes and yields. Companies that remove the unused pads do so primarily to extend drill bit life and produce better vias in the boards, which they considered the primary reliability issue. For those that keep the unused pads, the primary reason given is that they believe it helps manage Z-axis expansion of the board due to Coefficient of Thermal Expansion (CTE) stresses. However, with the newer materials being utilized for Pb-free assembly, the Z-axis CTE concern seems to have abated. In general, the companies responding did not feel that removing the unused pads would create a reliability issue. All suppliers said that their response was the same regardless of whether polyimide glass or epoxy glass materials were involved.

Introduction

Non-functional pads are pads on internal or external layers that are not connected to any active conductive patterns on the layer. Figure 1 shows removal of NFPs on a single plated via.

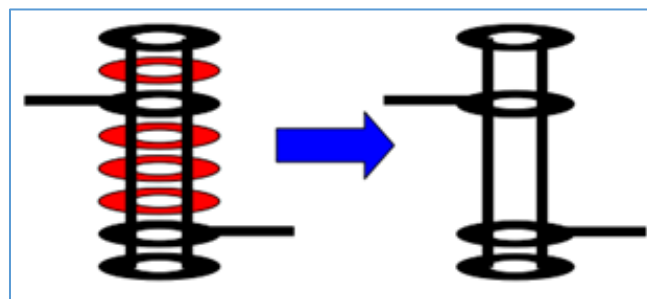


Figure 1 Schematic of NFP Removal [12]

Keywords: non-functional pads, NFP, reliability, survey

Industry Survey

DfR Solutions performed an industry survey of board manufacturers to learn the following:

- How common is the removal of nonfunctional pads from board designs by manufacturers?
- What considerations, if any, factor into the decision to remove these pads?
- Does removal have a known impact on printed board reliability?

Experimental Procedure

The survey consisted of the following:

For the board described below, please answer the following questions:

- IPC Class 3 Requirements
- FR4 (170C) and Polyimide (220C)
- HASL Finish, Sn63Pb37 only (not Pb-free)
- Thickness range: 0.020" to 0.125"
- Layer Count: 16 max
- Inner Copper (oz): 0.5 to 2.0, Outer Copper (oz): 1.0 to 3.0

Questions:

What is your procedure with respect to non-functional inner layer pads?

- *Do you keep them or remove them as a function of board material type, overall thickness, layer count, copper thickness?*
- *Is this a standard practice?*
- *If you remove or don't remove non-functional pads, what is the reason for doing so?*
- *If you remove them, do you have reliability data that you could share indicating whether there is or is not a reliability issue?*
- *Is the answer the same for epoxy glass and polyimide board materials?*
- *Is the answer the same if the circuit is high speed?*

Your name: _____

Company: _____

Email address: _____

The survey was sent out to 22 printed board fabrication companies.

PB (Printed Board) Fabricators

Fourteen US printed board fabricators participated in the survey. An additional eight fabricators received the survey but did not respond.

Results

DfR received responses from fourteen US-based PB shops. The following paragraphs provide insight into their responses for each question in the survey.

What is your procedure with respect to non-functional inner layer pads?

To summarize the surveyed PB fabricators responses:

1. 5 companies simply remove them
2. 5 others stated that they would remove the pads, but typically after receiving permission from their customer.
3. 4 stated that they never remove them

In addition to the fabricator survey request, DfR put a notice on LinkedIn asking for a response to this question. Only one response was received from a fabricator's representative.

"I'll just answer your question for the fabricator. We generally prefer to remove them unless directed otherwise to reduce automated optical inspection (AOI) time. An exception (unless directed to keep them), would be if we need the additional copper for stability in lamination (if it's a very sparse circuit layer)."

Thus it is a standard practice for this supplier to remove them.

Do you keep them or remove them as a function of board material type, overall thickness, layer count, copper thickness?

In all responses, the board material type, thickness, layer count, and copper thickness did not alter the company's decision to either keep or remove the unused pads.

Is this a standard practice?

Regardless of whether the pads were kept or removed, every company responded that it was their standard practice.

If you remove or don't remove non-functional pads, what is the reason for doing so?

This question provided the most interesting responses as it provided insight into each company's reasoning.

Why Remove Unused Pads?

- *"The drill bit will not easily be hurt and cause hole-wall roughness. (The non-functional inner layer pads are also always drilled even when the via and via hole size is small. The drill bit is also small and may easily be damaged if the copper remains for each layer.)"*
- *"We minimize drill wear by removing them, especially on high layer counts with thick copper."*
- *"Drill life is reduced if all layers have unused lands. Drill breakage is also a concern."*
- *"Removal of unused lands in wiring plane with tight registration of line to land requirements."*
- *"To protect the drill bit from damaging and produce clean hole wall free of nodules."*
- *"We remove them to reduce the opportunity of creating shorts especially in a BGA area where typically trace/space is already fairly dense and to reduce the drill wear. The more copper we*

drill through, the more heat is generated reducing the possible hit count and having cleaner holes.”

- *“To enhance the drill hole quality, we prefer to drill through as little metal as possible. The effect of the unused pads is to wear the drill bit more rapidly, which shows up as gouging and poor drill quality.”*
- *“Non-functional pads are normally removed to eliminate the possible misregistration perception by end user.”*
- *“We remove them because it allows for a better product after etching.”*
- *“For hole wall support on rigid product to reduce drill wear.”*

Why Leave Unused Pads?

- *“In our case, concern for accidental removal of a functional pad.” However, I began in business at TI and we always removed nonfunctional pads because our concern was bond strength of the electroless copper to the internal surface copper. If you didn’t need the copper, remove it. Also less chance for shorting in plane areas for nonfunctional pads.*
- *“We believe that they anchor the hole and improve reliability. However, we have begun questioning this and have a DOE in progress to investigate.”*
- *“The more copper that can be retained on any layer, the better the dimensional stability will be. Providing a complete pad stack (with the exception of plane layers) has improved registration and allows for proper DPA (destructive part analysis). With this ability to verify registration or misregistration anywhere within the product panel provides a great benefit. The additional copper also allows for better chip evacuation and prevents or greatly reduces clogged flutes.”*
- *“Primarily electrical test shorts and AOI call outs for shorts”*

Summary of Responses

In all cases, remove or leave, the primary reason was to improve the respective fabricators process and yields. The companies that remove the unused pads do so primarily because they want to extend drill bit life and produce better vias in the boards, which they consider the primary reliability issue. For those that keep the unused pads, the primary reason is that they believe it acts as a multi-flanged rivet to combat interlayer damage within the PB. Such delamination is the result of non-homogeneous Z-axis expansion of the board due to differences in the Coefficient of Thermal Expansion (CTE) of the disparate materials.

In general, the companies responding did not feel that removing the unused pads would create a reliability issue.

Reliability Data

DfR did not expect to get many responses to these questions due to the proprietary nature of the data. However, some of the responses detailed how the fabricators gather appropriate data to make their decisions.

If you remove non-functional pads, do you have reliability data that you could share indicating whether there is or is not a reliability issue?

“We added two test coupons under the rails of the working panel. (See Figure 2.) The test coupon includes the min. hole size and max. hole size and our min. trace. The hole we designed included each layer’s pad. When we complete the 1st copper plating, our lab cross sections these two coupons and checks the hole wall roughness, copper thickness, and the layer to layer registration. If the coupon showed any layer without an annular ring then we increase the check quantity. If the result was unacceptable then we may check all working panels and scrap the defect boards in the PTH process. Engineering would then investigate to check if the issue happened in inner layer process, lamination process or drill process. After finding the root cause, we correct the issue and replace the defective boards.”

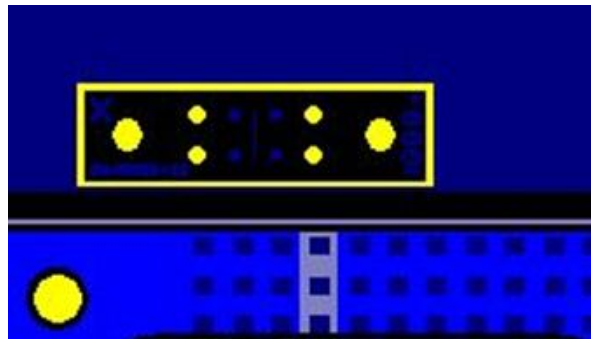


Figure 2. One of Two Test Coupons on Panel

“This is a combination of many factors. We have seen in the past when we have a high rate of gouging (.0007), we have multiple initiation points for plating folds that are always the first to fail. Having non-functional pads reduces this potential. Also depending on construction and how resin rich the stack-up may be we see a higher amount of lifted pads and or actual cracking of the ED foil in the high layer count thick products that have minimal interconnects. Even though your scenario speaks about (not Pb-free) we see there are many CM’s that will still subject the product into those temperature ranges especially for selective connectors that require a solder fountain application. We did have a product for an ATE customer that had active components (slightly over your thickness as it was .188). They had multiple failures until the non-functional pads were added back and then there were no further issues. Same design just pads vs no pads. We have also seen more instances of larger layer count product coming in with the pads removed. From an electrical standpoint, the additional capacitance is not good for signal integrity so they are required to be removed. For this type of product, we need to make sure we increase the plated copper to .0015 minimum as we had seen failure with .0008 min copper thickness. We also did a reliability test with the attached pad stacks. I am not able to share the results with you due to NDA.”

- *“PTH life can be affected with the addition of unused lands for “smaller” diameter vias; data is out on IST type fails. Larger PTH diameter may have improved life with unused lands, not enough data in the open.”*
- *“Yes, we provide TDR impedance report when impedance is requested, reliability report, and cross section.”*
- *“The reliability data we would have is in the form of the 6012 class 3 requirement for the specific customer part. And what would be included in the C of C package supplied with the part. We do perform part number and material qualification through an independent lab. We typically cannot share this data.”*
- *“Based on customer returns or more accurately the lack of customer returns, the practice of unused pad removal does not adversely affect functionality or reliability.”*
- *“It is not a reliability issue on rigid boards. Unused pads just wear on the drills especially those with higher layer counts and high copper weights.”*

Is the answer the same for epoxy glass and polyimide board materials?

All suppliers said that their response was the same regardless of whether polyimide glass or epoxy glass materials were involved.

Is the answer the same if the circuit is high speed?

- *“Yes. More so for high speed because non-functional pads (NFP's) have a signal integrity (S.I.) impact on the holes (from a supplier typically removes the unused pads).”*
- *“No, for high speeds, these unused lands increase loss (>10Gbps) (from a supplier that typically keeps the pads).”*

Rigid Flex

Several suppliers also responded that if the board was a rigid flex configuration, then they would leave the unused pads in place to provide additional reinforcement for the Kapton Mylar flex material.

Additional Insight from Industry

Technical papers and discussions that address this issue were also examined. (No company or individual who participated in the survey is cited in this section.) Impact to both design function and reliability are seen with the use of NFPs.

Industry Publications

In “Signal Integrity Analysis of a 26 Layers Board with Emphasis on the Effect of Non-Functional Pads” [1], Ciccomancini Scogna shows that non-functional pads consistently impact insertion loss. Insertion loss provides information about both the quality of the signal and its bandwidth and is one major characteristic which help describe high speed interconnect behavior. Degradation of signal performance is seen when NFPs are used and improvements are achieved by removing them.

The National Physical Laboratory presented a webinar on “Through Hole Reliability for High Aspect Via Holes” [2]. Microsections of failed vias showed a high percentage of the failures were adjacent to non-functional pads, even though they were away from the center portion of the vias where failures typically occur. Failures also occurred earlier. See **Figure 3** where inclusion of NFPs is shown in the leftmost, black line.

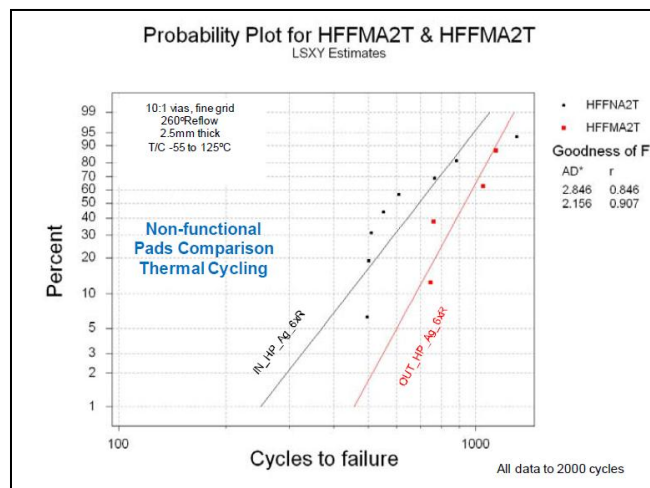


Figure 3. Earlier Fails with NFPs

The paper, “Discussion on non functional pad removal / backdrilling and PCB reliability” [3] indicates that “the continuing trend (which as always is product design specific) is as follows: With smaller vias/higher aspect ratio (.008" / 0.2mm to .020" 0.5mm) the inclusion of internal lands is negative (10-30% reduction in long term performance). Conversely, with larger holes/lower aspect ratio (via size - .020"+ / 0.5mm+) the inclusion of internal lands is positive (10-15% increase in long term performance).”

In “Design and Construction Affects [sic] on PWB Reliability,” Paul Reid states: “Generally speaking the presence of non-functional pads is a deterrent to the reliability of PWBs” [4]. He further points out that one or two non-functional pads that are not in the center of the PTH generally improve reliability when compared to the same PTH with NFPs at every layer. He describes a condition call “telegraphing” where there is so much copper at PTHs the material is “resin starved” between pads and you can see the image of this “pancake stack” of copper in the dielectric; the image is “telegraphed” to the surface. When the dielectric is thin and the copper thick, the condition is exacerbated and reliability is significantly reduced. The high spots create regions where the epoxy is squeezed out. Lack of sufficient epoxy can result in adhesion issues and can provide potential pathways for electrochemical migration to occur. Reid’s schematic is shown in Figure 4. He indicated that is a condition of concern but acknowledged not seeing any real rejections for this condition.

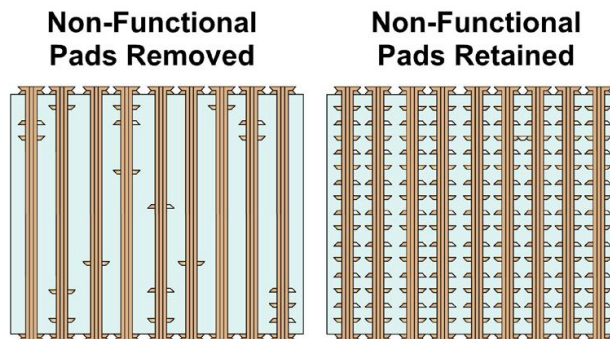


Figure 4 NFP Schematic [4]

In his book *High-speed Circuit Board Integrity* [5], Thierauf states that in many situations, NFPs are harmless. However, they can be troublesome in high speed signaling applications, especially with thick, multilayer boards. **Figure 5** shows how a NFP can capacitively couple to a return plane, lowering the impedance seen by a signal passing along the via.

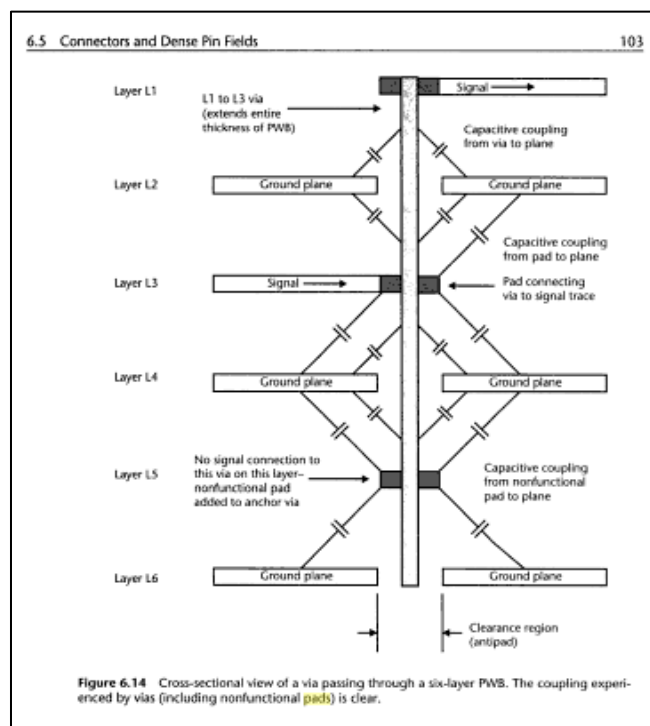


Figure 5. NFP Capacitively Coupling to Plane

In Chapter 20 “Thermal Stress Issues in Plated-Through-Hole Reliability,” from *Thermal Stress and Strain in Microelectronic Packaging* [6], the authors refer to industry reports that NFPs are beneficial for PTH life. Modeling with and without NFPs of the Von Mises barrel stress was performed for epoxy glass and Kevlar polyimide multilayer boards, as seen in **Figure 6**.

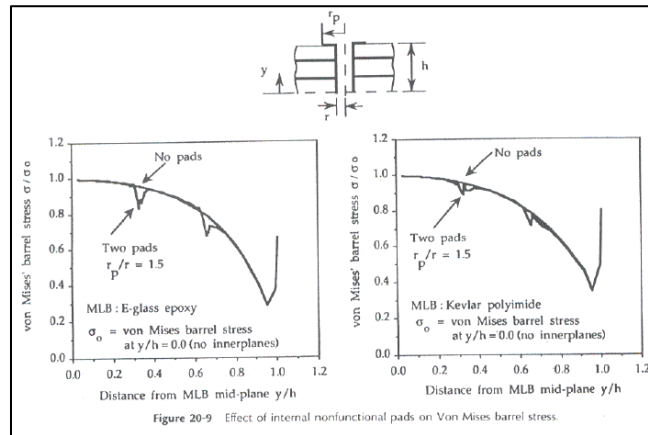


Figure 6. Effect of NFPs on Barrel Stress

Industry Expert Opinions

On April 4, 2014, the Circuitnet Ask the Experts column addressed the topic: “Removal of Non-functional Pads from Inner Layers” where a reader asked: “Should we remove non-functional pads from inner layers. In some cases, it may be necessary to free up space between rows of pads to route additional trace data. I’ve read articles that favor both options. What is your opinion?” Responses from the experts included:

- “Non-functional copper is generally used to balance plating. On inner layers, with nonfunctional copper, this would be a very sophisticated lay-up, as it sounds as if there are embedded via’s and high-density features. With that assumption, replacing non-functional copper, with functioning copper features is a 1:1 trade-off. These non-functional features are used to “thieve” amperage and/or plating away from sensitive areas. By putting functional copper in these areas, you are balancing the design, to be less dependent on non-functional copper.” Rodney Miller Capital Equipment Operations Manager, Specialty Coating Systems
- “An interesting question to be sure. Fabricators normally do prefer it, because it makes drilling easier. Copper is a tough, stringy metal, and in general it’s a pain to drill through. On the other hand, removal of all unused pads on thick, high layer count PWBs may result in long distances between points where the PTH copper is “tied” into the hole wall. This can result in somewhat reduced reliability (I’ve seen examples of this). Selective removal is one option that may provide the routing flexibility needed, and easy fabrication, while maintaining a few tie points along the depth of high-aspect-ratio vias. One approach might be to leave lands on selected plane layers, even if unattached. The plane layers are not used for signal routing so the presence of pads will not impede routing.” Fritz Byle, Process Engineer, Astronautics
- “This is a very interesting question. What we find is that, from a reliability point of view, based on thermal cycle evaluations, removing non-functional pads increases the reliability of the PWBs to some degree. It is thought that having non-functional pad “in” will cause the drill to work harder as it drills through the extra copper offered by non-functional pads and increase

the temperature internally, aging the material in the barrel of the hole. Having non-functional pad in is thought to have a tendency to provide stress risers that focus the strain into the barrel of the PTH. Whatever the case what we find repeatedly is that non-functional pads "in" reduces thermal cycle to failure by 10% to 20%. What I suggest that you do is remove most of the non-fictional pads in the central zone of the PWB. Leave in one or two non-functional pad in the top or bottom third of the stackup. This will give you the most reliable construction. You can always test the two different constructions to prove my contentions, using thermal cycling methods." Paul Reid, Program Coordinator, PWB Interconnect Solutions

- *"Non-functional pads should be removed if this is a signal via. Non-functional pads do not improve reliability from a barrel fatigue perspective and can greatly reduce manufacturability in the drilling process (dulls the drill bit). If the via is used for assembly, such as a through-hole solder joint, then non-functional pads can prevent hole wall pull away." Dr. Craig D. Hillman, CEO & Managing Partner, DfR Solutions*
- *"Eliminating non-functional pads is a great way to gain some real estate on all types of PCB's, but this practice should be used with caution on flex and rigid-flex printed circuit boards. Copper plating generally does not bond to flexible materials in the plated through hole as well as it bonds to rigid materials. This is especially true on controlled impedance flex and rigid flex where thicker flex dielectrics are incorporated into the material stack up. All pads, both functional and non-functional, provide points dispersed along the plated barrel for the plating to adhere to. If all non-functional pads are removed causing the gap between functional pads becomes too great, the plating may start to separate from the hole wall. I would recommend leaving at least some of the non-functional pads in place on flex and rigid flex boards and attempt to keep them evenly dispersed along the plated through hole wall to avoid possible plating separation." Mark Finstad, Senior Applications Engineer, Flexible Circuit Technologies*

From these comments, it is clear that there is not a "one size fits all" approach to non-functional pad removal. Companies need to devise a strategy based on the design and materials used and document those needs clearly to their printed board fabricators. The experts do all recommend removal of NFPs where possible.

Printed Board Fabricator Guidance

PB Fabricators routinely recommend removal of non-functional pads. Multek states that including NFPs adds unnecessary spacing and decreases layer yield [7], illustrated in **Figure 7**.

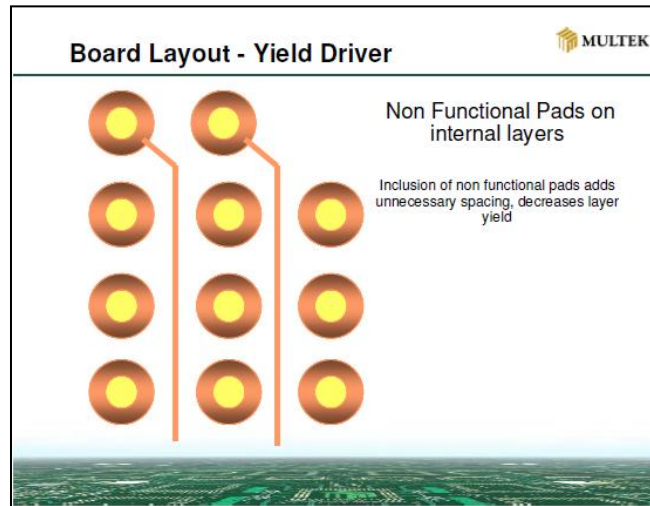


Figure 7. Multek Recommendation

For improved signal integrity at higher frequencies, Sanmina indicates that removal of non-functional pads and via backdrilling are two commonly used via optimization techniques [8].

Design & Application Note Guidance

Altera offers guidance in at least two application notes [9, 10]. In order to minimize parasitic capacitance in high speed (Gbps) transceiver designs and to optimize vias in high speed channels in general, eliminating all non-functional pads is recommended. Altera further recommends removing NFPs in all high aspect ratio vias.

In “Practical Guidelines for Implementing 5 Gbps in Copper Today, and the Roadmap to 10 Gbps” [11], the authors recommend removal of NFPs, as seen in **Figure 8**.

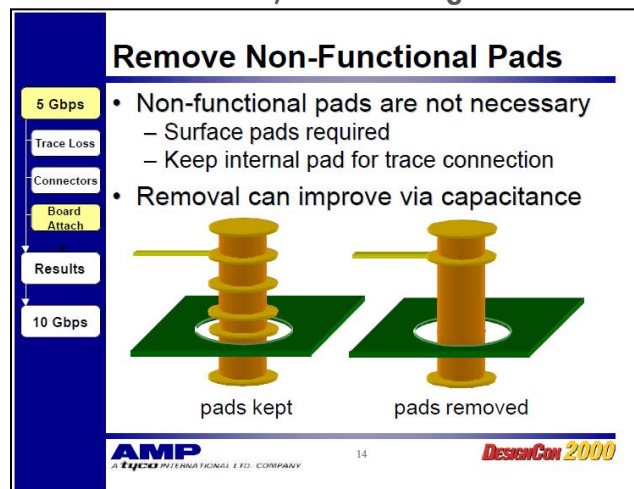


Figure 8. NFP Recommendation

Conclusions

The survey results do not indicate any specific reliability issue associated with the removal of unused pads for standard rigid multilayer boards. Two thirds of the fabricators that responded removed the pads routinely or after approval from their customer. DfR recommends that designers include this type of acceptance requirement on either their fabrication drawings or their purchase orders.

One supplier for military PBs did indicate that they felt the removal of pads could present a reliability issue. When queried further, it was determined that the issue was with very small drill bits on a 22+ layer board. In that instance, the additional stiffness from the pads provided support in the drilling operation where the aspect ratio was high.

However, some of the responses and the literature search indicate that the non-removal of unused pads could result in a phenomenon called “telegraphing” where the epoxy is squeezed so thin that there is a little left between each layer which can be a reliability issue [4].

Acknowledgements

This work was supported by those printed board fabricators who participated in the survey.

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IMAGE REFERENCE

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